

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/624,671	NAKAMURA ET	AL.
Examiner	Art Unit	
HELEN O. CHU	1795	

	SEARCHED		
Class	Subclass	Date	Examiner

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Palm and Edan (Inventor Search)	3/20/2008	НС		
World Wide Web	3/20/2008	НС		
East Search (Updated)	3/20/2008	НС		
STN search	3/20/2008	Usha		